

Room temperature epitaxial growth of (001) CeO₂ on (001)LaAlO₃ by pulsed
laser deposition

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Abstract

The room temperature epitaxial growth of CeO₂ on lattice matched (001) LaAlO₃ substrates by using pulsed laser deposition (PLD) method under various oxygen partial pressure (P_{O2}) is demonstrated. X-ray diffraction analysis with 2-Theta/rocking curve/Phi-scan, cross-sectional transmission electron microscopy with selected area diffractions are used to characterize structural of grown films. The epitaxial (001) CeO₂ can be achieved at room temperature under P_{O2} less than 2×10^3 Torr. The best quality of grown film is obtained under P_{O2} = 2×10^5 Torr and degraded under P_{O2} = 2×10^6 Torr due to oxygen deficiency in structure. The epitaxial relationship between CeO₂ and LAO is confirmed to be (001)CeO₂//(001)LAO, [100]CeO₂//[110]LAO and [010]CeO₂//[-110]LAO. No obvious reduction reaction occurred, from Ce⁺⁴ turned into Ce⁺³ states, as reducing oxygen partial pressure during growth by PLD.

Keyword : CeO₂, room temperature epitaxy, PLD, LAO, XPS.